



# **FQD2N80 / FQU2N80**

## 800V N-Channel MOSFET

## **General Description**

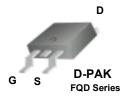
These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

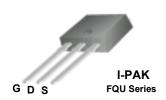
This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switch mode power supply.

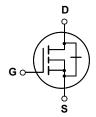
## **Features**

- 1.8A, 800V,  $R_{DS(on)} = 6.3\Omega @V_{GS} = 10 V$
- Low gate charge (typical 12 nC)
- Low Crss (typical 5.5 pF)
- Fast switching
- · 100% avalanche tested
- · Improved dv/dt capability
- · RoHS Compliant









## **Absolute Maximum Ratings** $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter		FQD2N80 / FQU2N80	Units
$V_{DSS}$	Drain-Source Voltage		800	V
I <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> = 25°C)		1.8	Α
	- Continuous (T <sub>C</sub> = 100°C)		1.14	Α
I <sub>DM</sub>	Drain Current - Pulsed	(Note 1)	7.2	Α
V <sub>GSS</sub>	Gate-Source Voltage		± 30	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy	(Note 2)	180	mJ
I <sub>AR</sub>	Avalanche Current	(Note 1)	1.8	Α
E <sub>AR</sub>	Repetitive Avalanche Energy	(Note 1)	5.0	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.0	V/ns
P <sub>D</sub>	Power Dissipation (T <sub>A</sub> = 25°C) *  Power Dissipation (T <sub>C</sub> = 25°C)  - Derate above 25°C		2.5	W
			50	W
			0.4	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150	°C
T <sub>L</sub>	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

## **Thermal Characteristics**

Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		2.5	°C/W
R <sub>0JA</sub> Thermal Resistance, Junction-to-Ambient *			50	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		110	°C/W

\* When mounted on the minimum pad size recommended (PCB Mount)

Symbol	Parameter	Test Conditions	\$	Min	Тур	Max	Units
Off Cha	aracteristics						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA		800			V
$\Delta BV_{DSS}$ / $\Delta T_{I}$	Breakdown Voltage Temperature Ip = 250 µA. Referenced to 25°C			0.9		V/°C	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 800 V, V <sub>GS</sub> = 0 V				10	μА
		V <sub>DS</sub> = 640 V, T <sub>C</sub> = 125°C	)			100	<u>.</u> μΑ
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	V <sub>GS</sub> = 30 V, V <sub>DS</sub> = 0 V				100	nA
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse	V <sub>GS</sub> = -30 V, V <sub>DS</sub> = 0 V				-100	nA
On Cha	racteristics						
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		3.0		5.0	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =10 V, I <sub>D</sub> =0.9 A			4.9	6.3	Ω
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 50 V, I <sub>D</sub> = 0.9 A	(Note 4)		2.4		S
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input Capacitance Output Capacitance Reverse Transfer Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz			425 45 5.5	550 60 7.0	pF pF pF
Switchi	ing Characteristics						
t <sub>d(on)</sub>	Turn-On Delay Time	V 400 V 1 0 4 4			12	35	ns
t <sub>r</sub>	Turn-On Rise Time		$V_{DD} = 400 \text{ V}, I_{D} = 2.4 \text{ A},$		30	70	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$R_G = 25 \Omega$			25	60	ns
t <sub>f</sub>	Turn-Off Fall Time	1	(Note 4, 5)		28	65	ns
Q <sub>g</sub>	Total Gate Charge	V <sub>DS</sub> = 640 V, I <sub>D</sub> = 2.4 A,			12	15	nC
Q <sub>gs</sub>	Gate-Source Charge	V <sub>GS</sub> = 10 V			2.6		nC
Q <sub>gd</sub>	Gate-Drain Charge	(Note 4, 5)			6.0		nC
Drain-S	Source Diode Characteristics at Maximum Continuous Drain-Source Dio		s			1.8	A
I <sub>SM</sub>	Maximum Pulsed Drain-Source Diode F					7.2	Α
$V_{SD}$	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = 1.8 \text{ A}$				1.4	V
t <sub>rr</sub>	Reverse Recovery Time	$V_{GS} = 0 \text{ V}, I_{S} = 2.4 \text{ A},$			480		ns
Q <sub>rr</sub>	Reverse Recovery Charge	dl <sub>F</sub> / dt = 100 A/μs (Note 4)			2.0		μС

- Notes: 1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 105mH, I<sub>AS</sub> = 1.8A, V<sub>DD</sub> = 50V, R<sub>G</sub> = 25  $\Omega$ , Starting T<sub>J</sub> = 25°C 3. I<sub>SD</sub>  $\leq$  2.4A, di/dt  $\leq$  200A/µs, V<sub>DD</sub>  $\leq$  BV<sub>DSS</sub>, Starting T<sub>J</sub> = 25°C 4. Pulse Test : Pulse width  $\leq$  300µs, Duty cycle  $\leq$  2% 5. Essentially independent of operating temperature

# **Typical Characteristics**

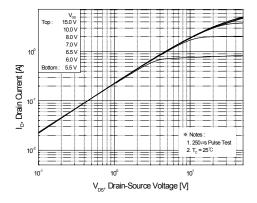


Figure 1. On-Region Characteristics

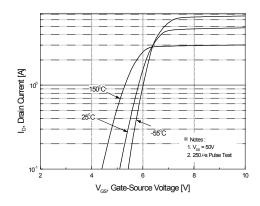


Figure 2. Transfer Characteristics

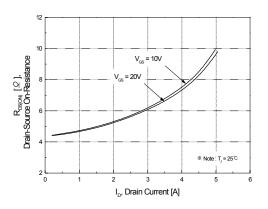


Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage

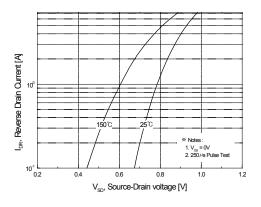


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

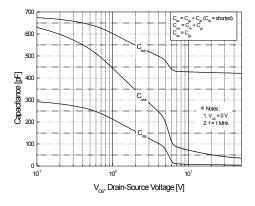


Figure 5. Capacitance Characteristics

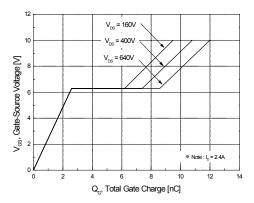
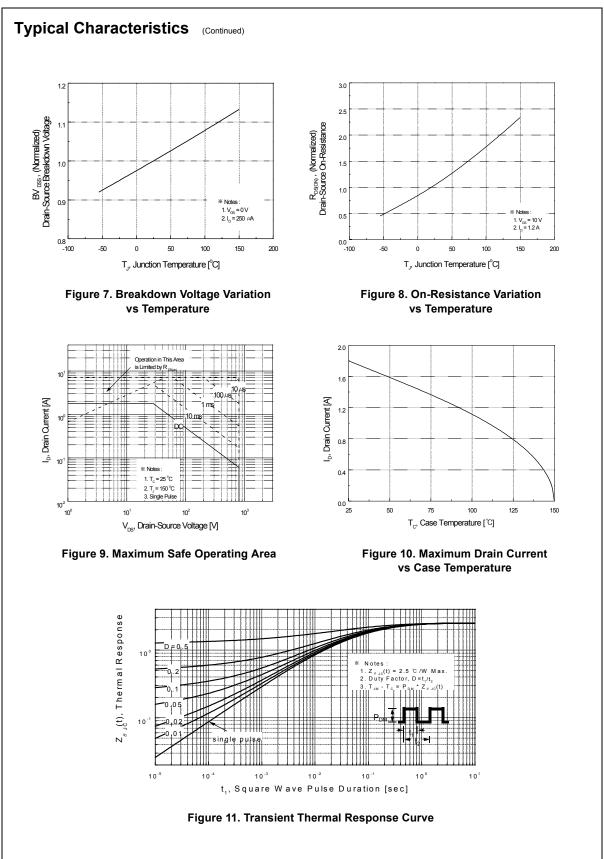
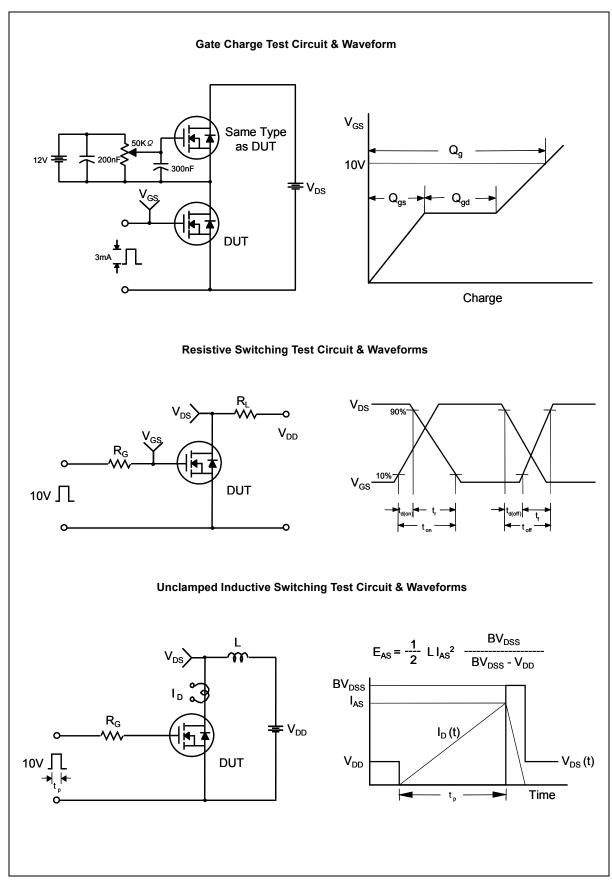


Figure 6. Gate Charge Characteristics

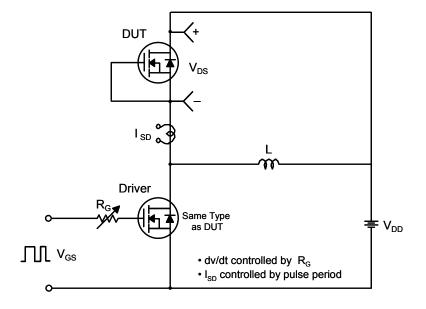
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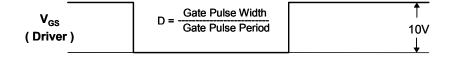


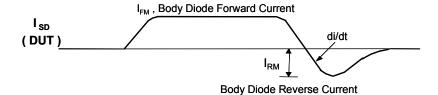
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## Peak Diode Recovery dv/dt Test Circuit & Waveforms







V<sub>DS</sub>
( DUT )

Body Diode Recovery dv/dt

V<sub>SD</sub>

V<sub>DD</sub>

Body Diode

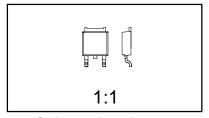
Forward Voltage Drop

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## **Mechanical Dimensions**

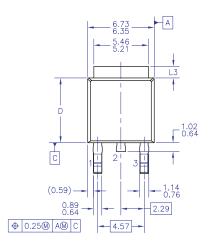
# TO-252 (DPAK) (FS PKG Code 36)



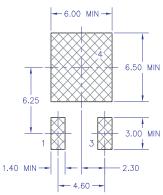


Scale 1:1 on letter size paper Dimensions shown below are in: millimeters

Part Weight per unit (gram): 0.33

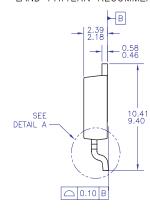


SEE NOTE D



LAND PATTERN RECOMMENDATION







0.127 MAX SEATING PLANE

- NOTES: UNLESS OTHERWISE SPECIFIED

  A) ALL DIMENSIONS ARE IN MILLIMETERS.

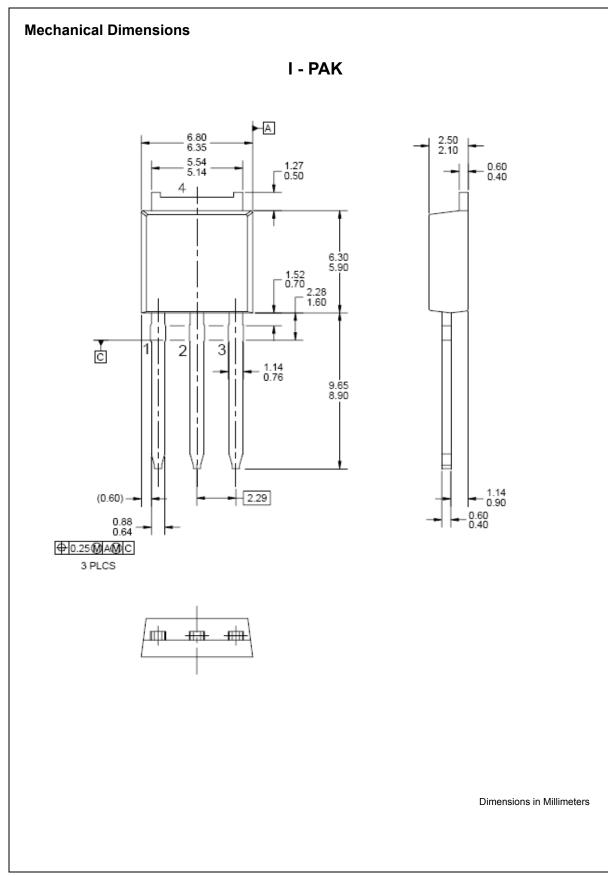
  B) THIS PACKAGE CONFORMS TO JEDEC, TO-252, ISSUE C, VARIATION AA & AB, DATED NOV. 1999.
  - DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.

  - HEAT SINK TOP EDGE COULD BE IN CHAMFERED CORNERS OR EDGE PROTRUSION.

    DIMENSIONS L3,D,E1&D1 TABLE:

	OPTION AA	OPTION AB
L3	0.89-1.27	1.52-2.03
D	5.97-6.22	5.33-5.59
E1	4.32 MIN	3.81 MIN
D1	5.21 MIN	4.57 MIN

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